Command and Data Handling System for the Panchromatic Fourier Transform Spectrometer

Dmitriy Bekker, Jean-François Blavier, Dejian Fu, Richard Key, Ken Manatt, Colin McKinney, David Rider, Stanley Sander, Thomas Werne, Amy Wu, Yen-Hung Wu

Jet Propulsion Laboratory
California Institute of Technology

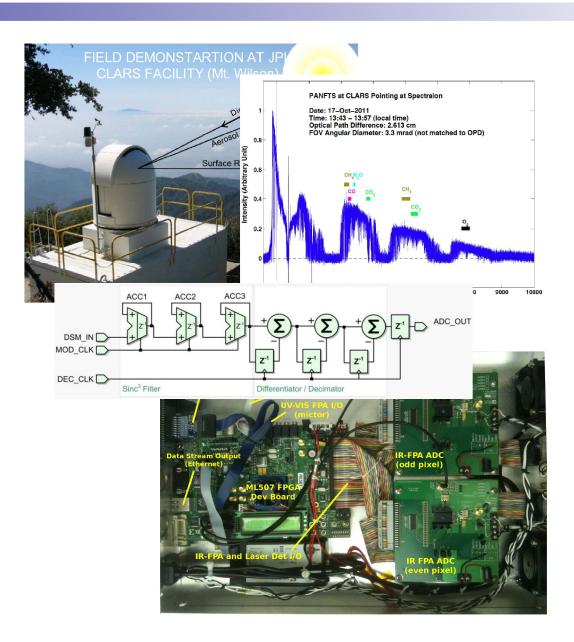


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Outline

- The PanFTS Instrument
- Breadboard Architecture
- FPA Data Acquisition
- Sigma-Delta Filter Design
- OPDM Control
- Functional Test
- Recorded Spectra
- Current Progress
- Conclusions





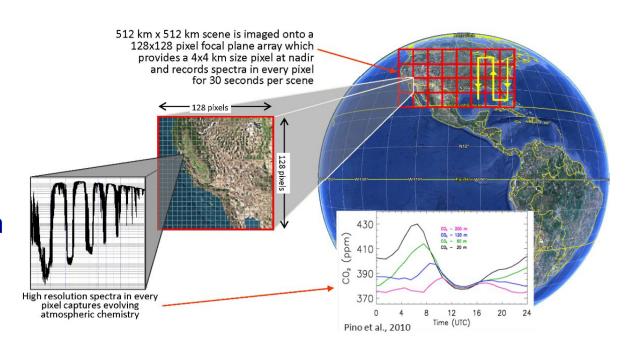
The PanFTS Instrument

- PanFTS is an Imaging Fourier Transform Spectrometer
 - Michelson interferometer (two in parallel)
 - "Camera" instead of traditional detector
 - Pictures recorded at high frame rates; path difference continuously varied
 - Fourier transform of each pixel recorded yields spectrum at observation
- Targeted for the Geostationary Coastal and Air Pollution Events (GEO-CAPE) mission – recommended by NRC Decadal Survey
- Multiple focal plane arrays (FPA) for IR and UV-Vis measurements
 - Goal: 128x128 pixels, 8kHz frame rate
 - Current progress: IR (Raytheon FPA) and UV-Vis (JPL developed), operation at CLARS site on Mt. Wilson, CA.
 - Present capability: trades spatial coverage for frame rate
- FPGA and commercial ADCs control/gather data from FPAs



The PanFTS Instrument

- Each of four cameras cover a 512 km square scene at nadir
 - 30 second scan time per scene
 - 16 minute coverage of continental U.S.
- Key technology developments
 - High efficiency optical layout
 - Novel optical path difference mechanism
 - High frame rate FPAs
 - Processing elements to handle huge data rates

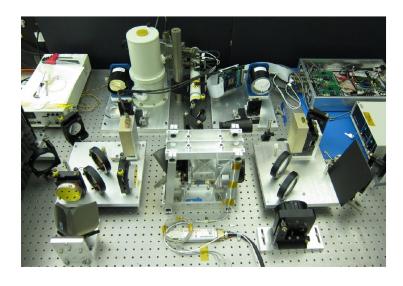


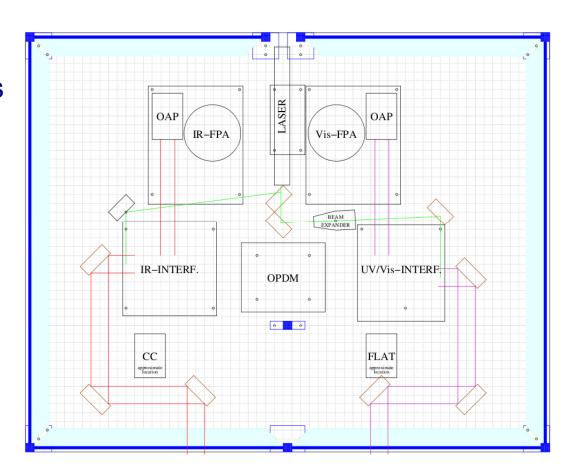
Imaging FTS observation scenario for GEO-CAPE mission



Optical Layout

- Two parallel interferometers (cover IR and UV-VIS)
 - Shared OPDM
 - Shared metrology laser
- 12-inch focal length off-axis parabolic mirrors



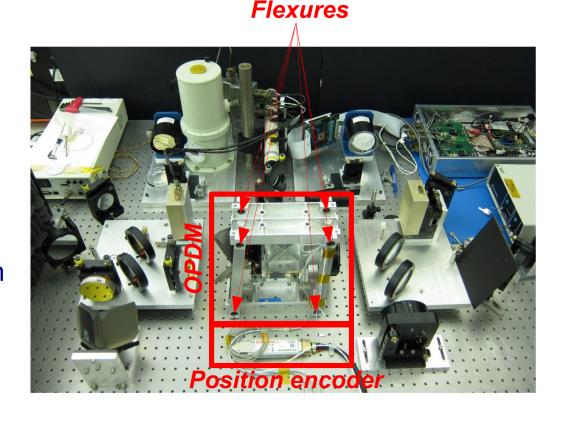


Optical layout of the PanFTS breadboard instrument



Optical Path Difference Mechanism (OPDM)

- Provides precise control of the optical path difference
- Flexure-based parallelogram design
 - Low tip/tilt error
 - "Infinite" life
 - Over 2.5M scans at vacuum and temperature (173K)
- Residual tip/tilt error in UV-VIS interferometer corrected by piezo stage
- Servo system drives voicecoil to control displacement

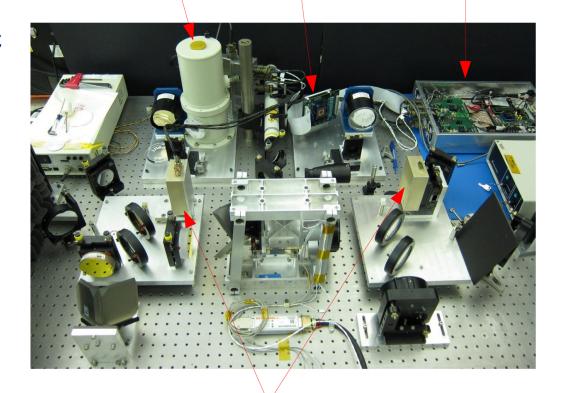




FPA Signal Chain

- JPL UV-VIS FPA (4x4)
 - First order sigma-delta ADC per pixel
- Raytheon IR FPA (256x256)
 - Windowed to 8x8 pixels
 - Analog output
- FPA data acquisition (FPGA)
 - Filter UV-VIS data
 - Capture IR data (ADCs)
 - Capture laser data
 - Synchronize all streams

IR detector FPA data acquisition UV-VIS detector



Laser detectors



OPDM Signal Chain

- Command and monitor state of translation mechanism
 - Servo controller board (JPL)
 - FPGA development board
 - Position encoder
- IP developed to:
 - Read OPDM position
 - Control OPDM with PID
 - Drive OPDM voice coil
 - Correct tip-tilt error
 - Monitor voltage, current, temperature

Data Display & Spectra Proc.

- OPDM control and FPA data acquisition communicate with single workstation
 - OPDM control and monitoring via RS232
 - FPA control via RS232
 - FPA data acquisition via Ethernet (TCP/IP)
- Data display via Matlab
- Data analysis via separate suite of programs



FPA Data Acquisition

- Simultaneous, synchronous capture from IR, UV-VIS, and laser detectors
- Virtex-5 FPGA used to control and collect data
 - UV-VIS FPA (digital)
 - IR FPA(analog) via ADCs
 - Laser (analog) via ADCs
- Sigma-delta filtering on FPGA for each UV-VIS pixel

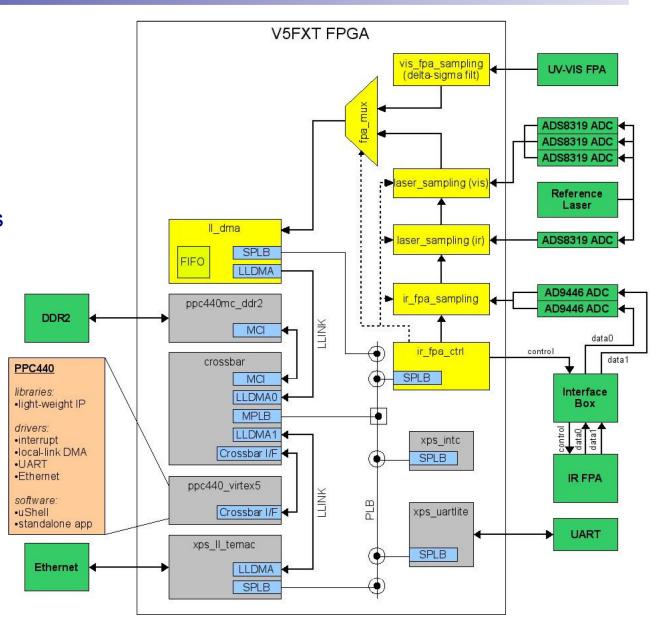


FPA Data Acquisition Electronics

- Embedded processor (PowerPC) controls data streams
- User commands sent via RS-232
- Data sent to workstation via Ethernet (TCP/IP)

FPA Data Acquisition

- ir_fpa_ctrl begins command cycle
- ir_fpa_sampling grabs one frame of data from IR ADCs
- laser_sampling (ir) grabs single channel laser data
- laser_sampling (vis) –
 grabs triple channel laser
 data
- fpa_mux switches from IR and laser stream to UV_VIS FPA stream and grabs one frame of UV-VIS data
- vis_fpa_sampling runs continuously, sigma-delta filtering UV_VIS data



Memory

Ethernet

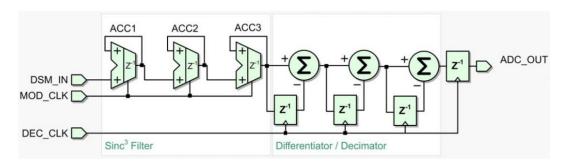


FPA Data Acquisition

- Embedded processor on FPGA runs a micro shell environment (µShell), accepting commands from user via RS-232
- Raytheon IR FPA (256x256) settings
 - Number of rows and columns, for windowing (in multiples of 8)
 - Row / column start coordinates (for windowing)
 - Frame rate, integration time
 - Bias, crosstalk, transimpedance, offset
- CPU check user input parameters are within range (IR FPA)
- Sigma-delta filtering performed in real-time per pixel (UV-VIS FPA)
- Currently, one mode in which all FPAs and laser detectors are simultaneously sampled
 - IR: windowed to 8x8, frame rate = 7.8125 kHz
 - UV-VIS: full array (4x4), sigma-delta filtered output rate = 7.8125 kHz

Sigma-Delta Filter Design

- UV-VIS FPA is essentially a sigma-delta converter without the digital filter on chip
- FPA output from modulator, 1-bit stream at 1.953 MHz (per pixel)
 - High sampling rate allows for simple anti-aliasing filter to be implemented on output
 - Pushes noise out to higher frequencies
- Digital filter needed to interpret modulator output with 16 bit resolution
 - 3 stage accumulator (Sinc³) followed by 3 stage differentiator-decimator
 - Replicated 16 times on FPGA (per pixel)
 - Decimation rate set to N=250, to produce 1.953 MHz / 250 = 7.8125 kHz



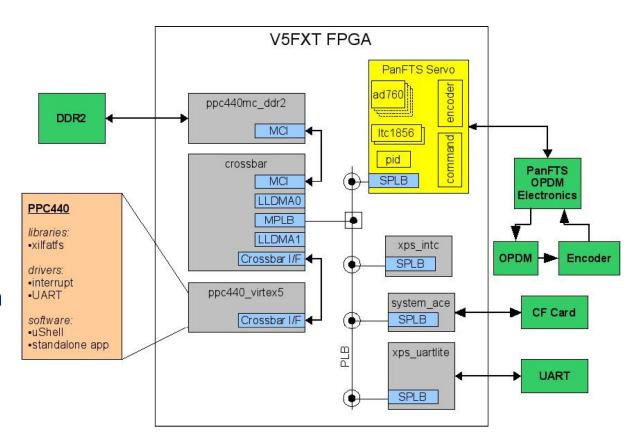
$$D_3(z) = \left(\frac{1-z^{-N}}{1-z^{-1}}\right)^3 X(z)$$

$$D_3(z) = \left(\sum_{i=0}^{N-1} z^{-i}\right)^3 X(z)$$



OPDM Control

- OPDM controlled by FPGA and servo system electronics (separate system from FPA data acquisition)
- OPDM commanded by standard discrete-time PID controller
 - Control loop calculation performed in FPGA fabric
 - PID parameters alterable from within software environment

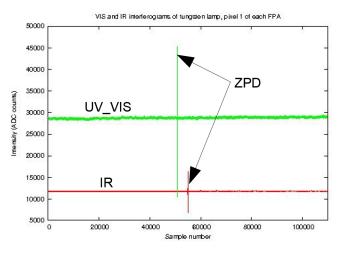


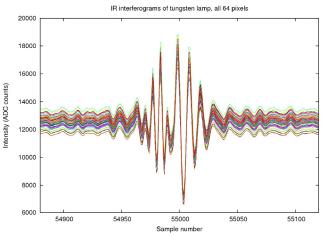
- Over-current protection monitors sustained large current draws in voice-coil, sends OPDM into "safe" mode
- FPGA keeps track of cycle count, stored on CF Card (used in lifetime test)

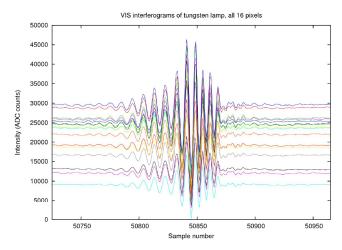


Functional Test

- Laboratory functional test used bright tungsten lamp to illuminate inputs of both interferometers (IR and UV_VIS)
- Spikes near the middle of the traces (see below) caused by constructive interference at zero path difference (ZPD), producing the strongest signal at the detectors
- Displacement in ZPDs due to being created in two separate interferometers
 - Possible to line up ZPD, moving cube corners (IR), flat mirror (UV_VIS)
 - Possible to operate IR interferometer with ZPD near one end of record, increasing spectral resolution in IR domain (advantage of PanFTS design)



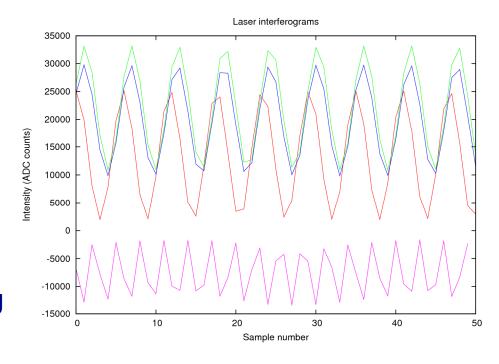






Functional Test

- Laser channels also recorded
 - Triple channel on UV_VIS side (because flat mirror requires tip/ tilt correction)
 - Single channel on IR side (no correction needed, using cubecorners)
- Phase measured on UV_VIS channel, compensated by driving piezo actuators in OPDM

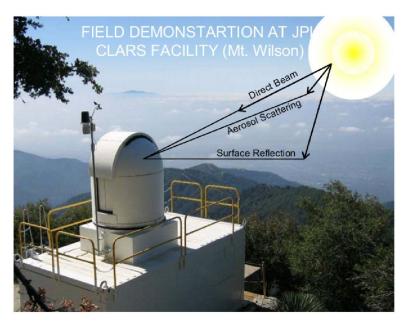


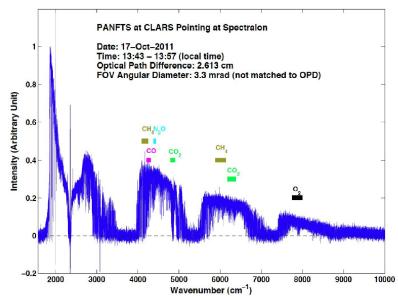
- IR laser laser appears at 2x frequency of UV_VIS, due to double passing of the optics in IR interferometer (shifted down for clarity)
- Laser signals are used to re-sample FPA data (IR and UV_VIS) onto a grid of equidistant optical path difference steps (post-processing)



Recorded Spectra

- Instrument moved to CLARS (California Laboratory for Atmospheric Remote Sensing)
- Replaced FPAs with single-element detectors
 - Low light levels produced by scattered sunlight
 - Low SNR on FPAs (debugging)
 - Used InSb for IR, Si for UV_VIS
- Measured absorption features from atmosphere above Mt. Wilson
 - Pointed instrument to Spectralon plate
 - Recorded and processed interferograms

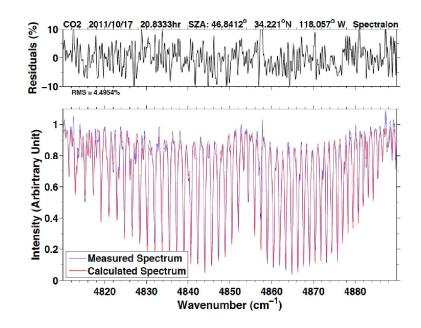


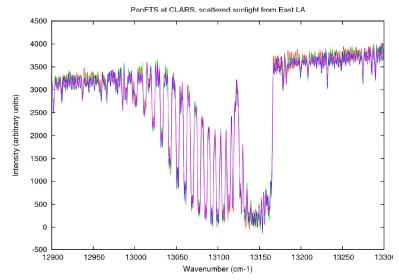




Recorded Spectra

- Comparing recorded spectrum to a computer model confirms FTS is working correctly
 - Section of spectrum at 2.06 µm (at right) showing CO₂ band fitted by a computer program (models atmosphere and instrument line shape) to produce synthetic spectrum
 - Residual between measurement and model dominated by random noise
- Interferometer stability confirmed by comparing four consecutive spectra from the East LA water reservoir
 - Showing spectral region containing 0.76 µm oxygen A-band
 - Consistency is clearly visible







Current Progress

- Main issue is low SNR level from the detectors, FPA data acquisition
- Raytheon IR FPA:
 - Progressively check SNR ratios to see where low SNR is most evident: ADCs, ADCs+preamp, ADCs+preamp+detector
 - Run data acquisition with ADCs at 20x oversampling, then perform averaging
 - Insert glass plate in cold dewar in front of detector to reduce thermal IR pickup from within the instrument
- JPL UV_VIS FPA:
 - Tweak FPA parameters (detector bias, injector charge, etc)
 - Work on using the FPA in an alternate run-time configuration
 - Compare SNR of raw data recording to filtered recording



Conclusions

- In its third and final year of the Instrument Incubator Program,
 PanFTS breadboard instrument moved to the CLARS facility
 - Able to capture atmospheric spectra of LA basin
 - Development of instrument moves to engineering model phase
- Progress in past year:
 - Addition of UV_VIS FPA to data handling system, with real-time sigmadelta filtering in FPGA
 - Ability to perform simultaneous recordings from IR and UV_VIS FPAs
 - Addition of multi-channel laser detectors to data handling system
 - Improvements in the OPDM and IR FPA configuration setting
- Near-term to-do:
 - Debug SNR issues with detectors
 - Add tip/tilt control to C&DH system



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